

Notice of References Cited	Application/Control No. 10/662,832	Applicant(s)/Patent Under Reexamination RENDON ET AL	
	Examiner Edward Wojciechowicz	Art Unit 2815	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0151145	10-2002	Lee et al	438/303
	B	US-			
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FOREIGN PATENT DOCUMENTS

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